

**Search Notes**

Application/Control No.

10/801,008

Examiner

Hieu Nguyen

Applicant(s)/Patent under  
Reexamination

BENJAMIN ET AL.

Art Unit

2817

**SEARCHED**

Class	Subclass	Date	Examiner
330	149	7/8/2005	HN
330	52	7/11/2005	HN
330	151	7/12/2005	HN
330	52	7/12/2005	HN
330	149	7/12/2005	HN
330	52	7/14/2005	HN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
MOTTOLA STEVEN J	7/11/2005	HN
NGUYEN KHANH V	7/11/2005	HN
MOTTOLA STEVEN J	7/13/2005	HN
NGUYEN KHANH V	7/13/2005	HN
MOTTOLA STEVEN J	7/14/2005	HN